

#### **Description**

The **vs18P10-T2** uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. It can be used in a wide variety of applications. It is ESD protested.

#### **General Features**

● V<sub>DS</sub> =-100V,I<sub>D</sub> =-18A

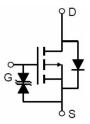
 $R_{\text{DS(ON)}}\!<\!100\text{m}\Omega \ \textcircled{0} \ V_{\text{GS}}\!\!=\!\!-10\text{V} \quad (\text{Typ:85m}\Omega)$ 

 $R_{DS(ON)}$  <120m $\Omega$  @  $V_{GS}$ =-10V (Typ:95m $\Omega$ )

- Super high dense cell design
- Advanced trench process technology
- Reliable and rugged
- High density cell design for ultra low On-Resistance

#### **Application**

- Power management in notebook computer
- Portable equipment and battery powered systems



Schematic diagram



## **Package Marking and Ordering Information**

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
VS18P10-T2	VS18P10-T2	TO-252-2L	-	-	-

#### Absolute Maximum Ratings (T<sub>C</sub>=25℃unless otherwise noted)

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	-100	V	
Gate-Source Voltage	V <sub>GS</sub>	±20	V	
Drain Current-Continuous	I <sub>D</sub>	-18	А	
Drain Current-Continuous(T <sub>C</sub> =100°ℂ)	I <sub>D</sub> (100℃)	-12	Α	
Pulsed Drain Current	I <sub>DM</sub>	-100	Α	
Single pulse avalanche energy (Note 5)	E <sub>AS</sub>	170	mJ	
Maximum Power Dissipation	P <sub>D</sub>	70	W	
Derating factor		0.47	W/℃	
Operating Junction and Storage Temperature Range	$T_{J}$ , $T_{STG}$	-55 To 175	$^{\circ}$	

#### **Thermal Characteristic**

Thermal Resistance,Junction-to-Case (Note 2)	R <sub>θJc</sub>	2.14	°C/W
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# Electrical Characteristics (T<sub>C</sub>=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =-250μA	-100	-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =-100V,V <sub>GS</sub> =0V	-	-	1	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V,V <sub>DS</sub> =0V	-	-	±20	μA
On Characteristics (Note 3)						
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =-250μA	-1	-1.9	-3	V
Drain Course On State Besistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =-10V, I <sub>D</sub> =-16A	-	85	100	mO
Drain-Source On-State Resistance		V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-16A		95	120	mΩ
Forward Transconductance	<b>g</b> FS	V <sub>DS</sub> =-50V,I <sub>D</sub> =-10A	5	-	-	S
Dynamic Characteristics (Note4)						
Input Capacitance	C <sub>lss</sub>	V = 50VV = 0V	-	3810	-	PF
Output Capacitance	Coss	$V_{DS}$ =-50V, $V_{GS}$ =0V, F=1.0MHz	-	129	-	PF
Reverse Transfer Capacitance	C <sub>rss</sub>	F=1.UIVID2	-	125	-	PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	t <sub>d(on)</sub>	$V_{DD}$ =-50V, $I_{D}$ =-16A $V_{GS}$ =-10V, $R_{GEN}$ =9.1 $\Omega$	-	16	-	nS
Turn-on Rise Time	t <sub>r</sub>		-	73	-	nS
Turn-Off Delay Time	t <sub>d(off)</sub>		-	34	-	nS
Turn-Off Fall Time	t <sub>f</sub>		-	57	-	nS
Total Gate Charge	Qg	V 50VI 40A	-	70	-	nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>DS</sub> =-50V,I <sub>D</sub> =-16A,	-	12.5	-	nC
Gate-Drain Charge	$Q_{gd}$	- V <sub>GS</sub> =-10V	-	15.5	-	nC
Drain-Source Diode Characteristics	<u>'</u>					
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =-10A	-	-	-1.2	V
Diode Forward Current (Note 2)	Is	-	-	-	-18	Α
Reverse Recovery Time	t <sub>rr</sub>	TJ = 25°C, IF =-16A	-	88.3	-	nS
Reverse Recovery Charge	Qrr	di/dt = 100A/µs <sup>(Note3)</sup>	-	65.9	-	nC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

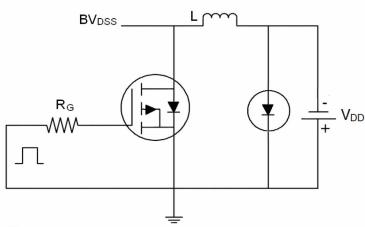
#### Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production
- **5**. EAS condition: Tj=25 $^{\circ}$ C,V<sub>DD</sub>=-50V,V<sub>G</sub>=-10V,L=0.5mH,Rg=25 $\Omega$

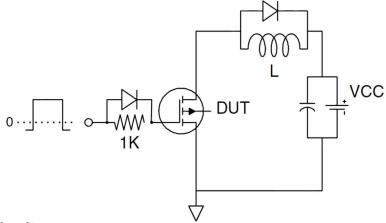


## **Test Circuit**

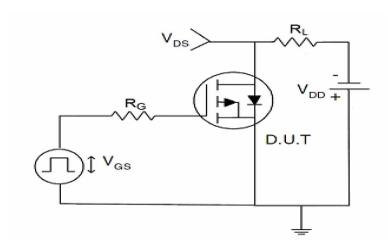
# 1) E<sub>AS</sub> Test Circuit



# 2) Gate Charge Test Circuit

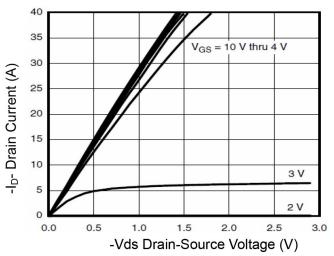


# 3) Switch Time Test Circuit

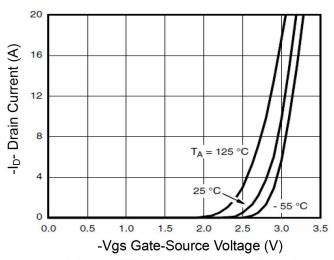




### **Typical Electrical and Thermal Characteristics (Curves)**



**Figure 1 Output Characteristics** 



**Figure 2 Transfer Characteristics** 

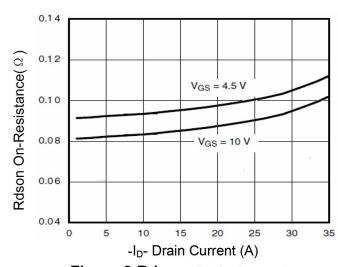


Figure 3 Rdson- Drain Current

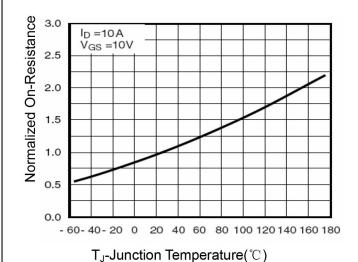


Figure 4 Rdson-JunctionTemperature

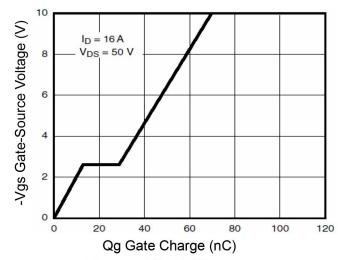


Figure 5 Gate Charge

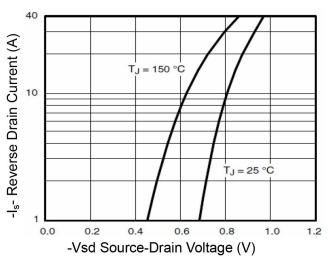
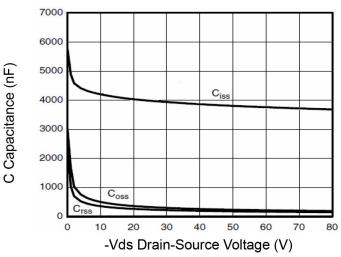


Figure 6 Source- Drain Diode Forward

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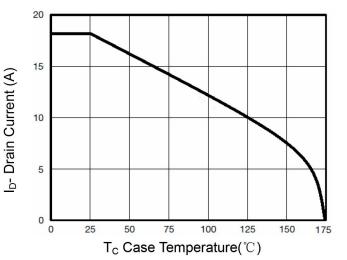
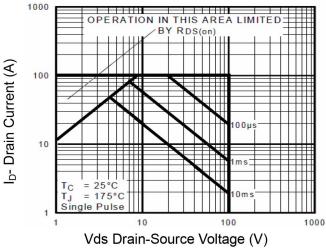


Figure 7 Capacitance vs Vds

Figure 9 Drain Current vs Case Temperature



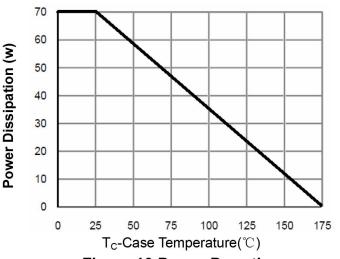
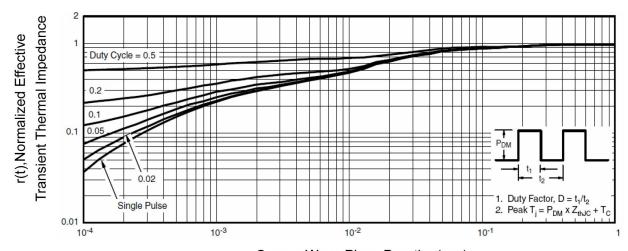


Figure 8 Safe Operation Area

Figure 10 Power De-rating



Square Wave Pluse Duration(sec)

**Figure 11 Normalized Maximum Transient Thermal Impedance**